10/551160

F-8848

## JC20 Rec'd PCT/PTO 28 SEP 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

**Applicant** 

Erwin PRISTNER

Serial No.

UNKNOWN (U.S. National Stage of

PCT/EP2004/003545 filed April 2, 2004)

For

METHOD AND DEVICE FOR DETECTING, DETERMINING AND DOCUMENTING DAMAGE, ESPECIALLY DEFORMATIONS IN LACQUERED SURFACES CAUSED BY

SUDDEN EVENTS

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## **INFORMATION DISCLOSURE STATEMENT**

Sir:

Submitted herewith is an Information Disclosure Citation together with a copy of EP 0 405 806. The degree of relevance of the documents referred to in the Information Disclosure Citation is set forth in the International Search Report also submitted herewith.

No copies are provided of references which are U.S. patents because the USPTO will attend to providing its own copies thereof.

Respectfully submitted,

Jordan and Hamburg LLP

By

C. Bruce Hamburg Reg. No. 22,389

Attorney for Applicant

Jordan and Hamburg LLP 122 East 42nd Street New York, New York 10168 (212) 986-2340

8848 ids CBH {PC01 }.wpd

## JC20 Rec'd PCT/PTO 28 SEP 2005

## F-8848

Form PTO-1	U.S. Department of Commerce	Atty. Docket No	.: F-8848	Sell so 5 usknown 0				
(Rev. 7-80) 42-44F (F-49)		Applicant: Erwin PRISTNER						
INI	FORMATION DISCLOSURE CITATION (Use several sheets if necessary)	Filing Date:		Group:				
	U.S.	PATENT DOCUM	ENTS			•		
Examiner Initial	Document Number	Date	Name	Class	Subclass		g Date If priate	
	US- 4,989,981	2/5/1991	Kawamura et al.					
	US- 4,715,709	12/29/1987	Yokota et al.	ļ				
	US- 3,968,559	7/13/1976	Karlsson					
	US- 5,844,801	12/1/1998	Morita et al.					
	FOREIC	ON PATENT DOCU	JMENTS	_		•		
	Document Number	Date	Country	Class	Subclass	Trans	Translation	
				<u> </u>		Yes	No	
			ED				N <sup>F</sup>	
ļ <u></u>	EP- 0405806	1/2/1991	EP		<u> </u>	<u> </u>		
<sup>c</sup> Concise	TION KEY: * English Abstract. F Concise statement of relevance provided in specif t portion of reference translated. O Englis	statement of refication. <sup>s</sup> Cond	relevance provided in cise statement of re	elevance	provided in	ort. IDS.		
<sup>c</sup> Concise	TION KEY: * English Abstract. F Concise statement of relevance provided in specif	e statement of r fication. <sup>s</sup> Cond th abstract only	elevance provided i cise statement of re - copy of reference	elevance e in pct se	provided in earch.	oort.		
<sup>c</sup> Concise	ATION KEY: * English Abstract. F Concise statement of relevance provided in specifit portion of reference translated. Description of reference translated.	e statement of r fication. <sup>s</sup> Cond th abstract only	elevance provided i cise statement of re - copy of reference	elevance e in pct se	provided in earch.	oort. IDS.		
<sup>c</sup> Concise	ATION KEY: * English Abstract. F Concise statement of relevance provided in specifit portion of reference translated. Description of reference translated.	e statement of r fication. <sup>s</sup> Cond th abstract only	elevance provided i cise statement of re - copy of reference	elevance e in pct se	provided in earch.	port. IDS.		